

## Notice of References Cited

Application/Control No. 09/622,020	Applicant(s)/Patent Under Reexamination LEE ET AL.		
Examiner	Art Unit		
Tu X Nguyen	2682	Page 1 of 1	

## **U.S. PATENT DOCUMENTS**

*		Document Number	Date		
		Country Code-Number-Kind Code	MM-YYYY	Name	Classification
	Α	US-6,388,997	05-2002	Scott, Logan	370/280
	В	US-6,212,405	04-2001	Jiang et al.	455/561
	O	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

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